

Search Notes

Application/Control No.

10/698,717

Examiner

VAN T. PHAM

Applicant(s)/Patent under
Reexamination

NAUKA ET AL.

Art Unit

2653

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--------------|-----------|----------|
| 369 | 126, 101. | 8/15/2005 | VP |
| 365 | 151 | 8/15/2005 | VP |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| East (US-PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB) 369/ and text search only see search history printout. | 8/15/2005 | VP |
| 365/145 and texsearch only (see search history printout). Consulted Wayne Young | 8/15/2005 | VP |
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